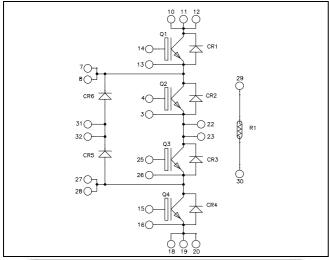
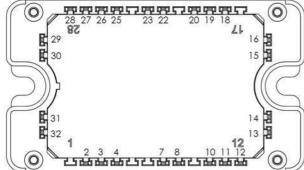


Three level inverter Trench + Field Stop IGBT3 Power Module







All multiple inputs and outputs must be shorted together Example: 10/11/12; 7/8 ...

Application

- Solar converter
- Uninterruptible Power Supplies

Features

- Trench + Field Stop IGBT3
 - Low voltage drop
 - Low tail current
 - Switching frequency up to 20 kHz
 - Low leakage current
 - RBSOA and SCSOA rated
- Kelvin emitter for easy drive
- Very low stray inductance
- High level of integration
- Internal thermistor for temperature monitoring

Benefits

- Stable temperature behavior
- Very rugged
- Direct mounting to heatsink (isolated package)
- Low junction to case thermal resistance
- Low profile
- RoHS Compliant

All ratings @ $T_j = 25$ °C unless otherwise specified

Q1 to Q4 Absolute maximum ratings (per IGBT)

Symbol	Parameter		Max ratings	Unit
V_{CES}	Collector - Emitter Voltage		600	V
Ţ	T _C =		80	
1C	I _C Continuous Collector Current	$T_C = 80$ °C	50	Α
I_{CM}	Pulsed Collector Current	$T_C = 25^{\circ}C$	100	
V_{GE}	Gate – Emitter Voltage		±20	V
P_D	Power Dissipation	$T_C = 25^{\circ}C$	176	W
RBSOA	Reverse Bias Safe Operating Area	$T_J = 150$ °C	100A @ 550V	

CAUTION: These Devices are sensitive to Electrostatic Discharge. Proper Handling Procedures Should Be Followed.



Q1 to Q4 Electrical Characteristics (per IGBT)

Symbol	Characteristic	Test Conditions		Min	Typ	Max	Unit
I_{CES}	Zero Gate Voltage Collector Current	$V_{GE} = 0V, V_{CE} = 600V$				250	μΑ
V _{CE(sat)}	Collector Emitter Saturation Voltage	$V_{GE} = 15V$	$T_j = 25$ °C		1.5	1.9	V
		$I_C = 50A$	$T_j = 150$ °C		1.7		v
$V_{GE(th)}$	Gate Threshold Voltage	$V_{GE} = V_{CE}, I_C = 600 \mu A$		5.0	5.8	6.5	V
I_{GES}	Gate – Emitter Leakage Current	$V_{GE} = 20V, V_{CE}$	=0V			600	nA

Q1 to Q4 Dynamic Characteristics (per IGBT)

Symbol	Characteristic	Test Conditions		Min	Typ	Max	Unit
Cies	Input Capacitance	$V_{GE} = 0V$			3150		
Coes	Output Capacitance	$V_{CE} = 25V$			200		pF
Cres	Reverse Transfer Capacitance	f = 1MHz			95		
Q_{G}	Gate charge	V _{GE} =±15V, I _C =50A V _{CE} =300V			0.5		μС
$T_{d(on)}$	Turn-on Delay Time	Inductive Switch	ning (25°C)		110		
$T_{\rm r}$	Rise Time	$V_{GE} = \pm 15V$			45		1
$T_{d(off)}$	Turn-off Delay Time	$\begin{array}{l} V_{Bus} = 300V \\ I_C = 50A \\ R_G = 8.2\Omega \end{array}$			200		ns
$T_{\rm f}$	Fall Time				40		
$T_{d(on)}$	Turn-on Delay Time	Inductive Switching (150°C)			120		
T_{r}	Rise Time	$V_{GE} = \pm 15V$			50		
$T_{d(off)} \\$	Turn-off Delay Time	$V_{\text{Bus}} = 300V$ $I_{\text{C}} = 50A$			250		ns
$T_{\rm f}$	Fall Time	$R_G = 8.2\Omega$			60		
Eon	Turn-on Switching Energy	$V_{GE} = \pm 15V$ $V_{Bus} = 300V$	$T_j = 150$ °C		0.43		mJ
E _{off}	Turn-off Switching Energy	$I_C = 50A$ $R_G = 8.2\Omega$	$T_j = 150$ °C		1.75		mJ
I_{sc}	Short Circuit data	$V_{GE} \le 15V ; V_{Bus} = 360V$ $t_p \le 6\mu s ; T_j = 150^{\circ}C$			250		A
R_{thJC}	Junction to Case Thermal Resistance					0.85	°C/W

CR1 to CR4 diode ratings and characteristics (per diode)

Symbol	Characteristic	Test Conditions		Min	Typ	Max	Unit
V_{RRM}	Peak Repetitive Reverse Voltage					600	V
I_{RM}	Reverse Leakage Current	$V_{R} = 600V$				150	μA
I_{F}	DC Forward Current		$Tc = 80^{\circ}C$		30		A
$V_{\rm F}$	Diode Forward Voltage	$I_F = 30A$	$T_j = 25^{\circ}C$		1.6	2	V
V F		$V_{GE} = 0V$	$T_j = 150$ °C		1.5		V
	D D T		$T_j = 25^{\circ}C$		100		
t_{rr}	Reverse Recovery Time		$T_{\rm j} = 150^{\circ}{\rm C}$		150	ns	ns
0	Davience Deservery Chance	$V_{R} = 300V$	$T_j = 25$ °C		1.5		C
Qrr	Reverse Recovery Charge		$V_R = 300 V$ di/dt = 1800A/µs	$T_j = 150$ °C		3.1	
E_{rr}	Reverse Recovery Energy	·	$T_j = 25$ °C		0.34		mJ
Litt	En Reverse Recovery Energy	$T_j = 150$ °C		0.75		1113	
R_{thJC}	Junction to Case Thermal Resistance					2.45	°C/W



CR5 & CR6 diode ratings and characteristics (per diode) Symbol Characteristic Test Conditions

Symbol	Characteristic	Test Conditions		Min	Typ	Max	Unit
V_{RRM}	Peak Repetitive Reverse Voltage					600	V
I_{RM}	Reverse Leakage Current	V _R =600V				150	μA
I_{F}	DC Forward current		$Tc = 80^{\circ}C$		50		A
V_{F}	Diode Forward Voltage	$I_F = 50A$ $V_{GE} = 0V$	$T_{j} = 25^{\circ}C$ $T_{j} = 150^{\circ}C$		1.6	2	V
t_{rr}	Reverse Recovery Time	$I_F = 50A$ $V_R = 300V$ $di/dt = 1800A/\mu s$	$T_j = 25^{\circ}C$ $T_i = 150^{\circ}C$		100 150		ns
Q _{rr}	Reverse Recovery Charge		$T_j = 25^{\circ}C$ $T_j = 150^{\circ}C$		2.6 5.4		μС
Err	Reverse Recovery Energy		$T_j = 25^{\circ}C$ $T_j = 150^{\circ}C$		0.60 1.20		mJ
R_{thJC}	Junction to Case Thermal Resistance					1.42	°C/W

Temperature sensor NTC (see application note APT0406 on www.microsemi.com for more information).

Symbol	Characteristic		Min	Typ	Max	Unit
R ₂₅	Resistance @ 25°C			50		kΩ
$\Delta R_{25}/R_{25}$				5		%
B _{25/85}	$T_{25} = 298.15 \text{ K}$			3952		K
$\Delta B/B$		$T_C=100$ °C		4		%

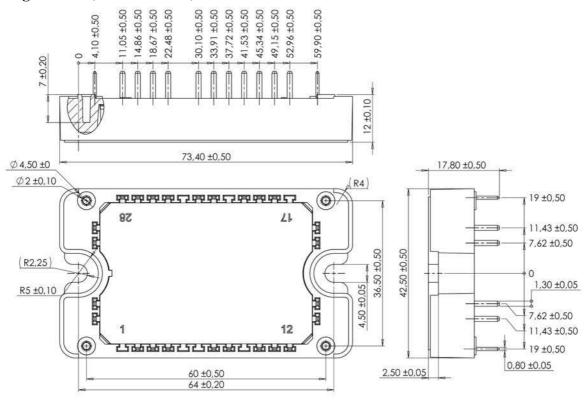
$$R_{T} = \frac{R_{25}}{\exp\left[B_{25/85}\left(\frac{1}{T_{25}} - \frac{1}{T}\right)\right]}$$
 T: Thermistor temperature R_T: Thermistor value at T

Thermal and package characteristics

Symbol	Characteristic				Max	Unit
V_{ISOL}	RMS Isolation Voltage, any terminal to case	e t = 1 min, 50/6	0Hz	4000		V
$T_{\rm J}$	Operating junction temperature range	-40	175			
T_{JOP}	Recommended junction temperature under switching conditions				T _J max -25	°C
T_{STG}	Storage Temperature Range				125	
$T_{\rm C}$	Operating Case Temperature				125	
Torque	Mounting torque	To heatsink	M4	2	3	N.m
Wt	Package Weight				110	g

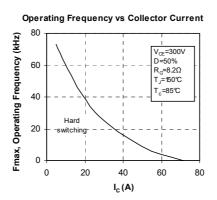


Package outline (dimensions in mm)

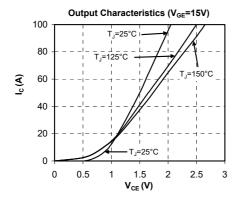


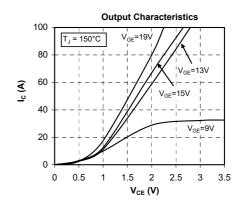
See application note 1906 - Mounting Instructions for SP3F Power Modules on www.microsemi.com

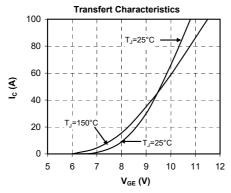
Q1 to Q4 Typical performance curve

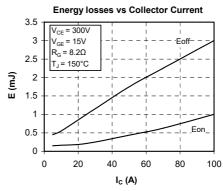


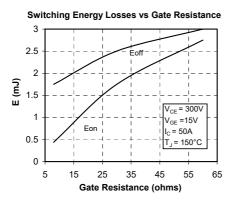


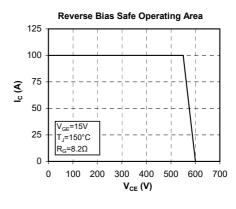


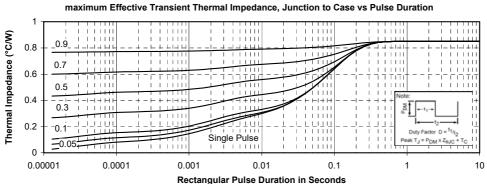






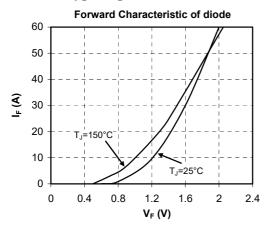




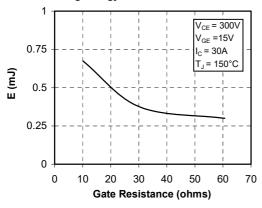




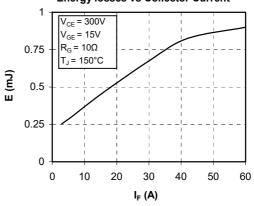
CR1 to CR4 Typical performance curve



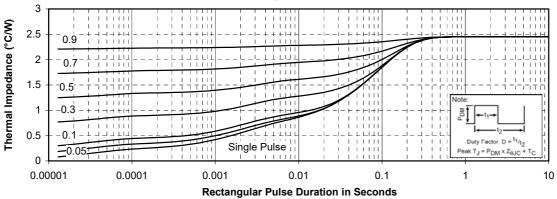
Switching Energy Losses vs Gate Resistance



Energy losses vs Collector Current

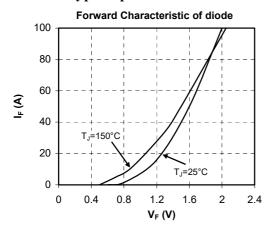


maximum Effective Transient Thermal Impedance, Junction to Case vs Pulse Duration

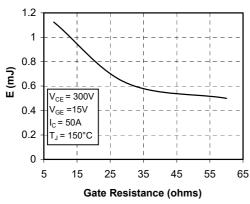




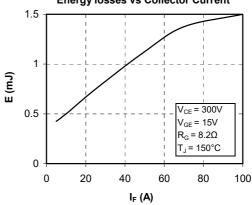
CR5 & CR6 Typical performance curve



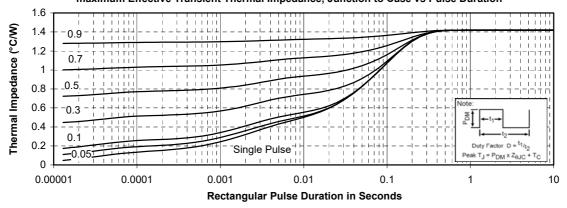
Switching Energy Losses vs Gate Resistance



Energy losses vs Collector Current



maximum Effective Transient Thermal Impedance, Junction to Case vs Pulse Duration



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